Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,196	NIIMI, AKIKO	
Examiner	Art Unit	
LAM & NOUVEN	2052	

SEARCHED			
Class	Subclass	Date	Examiner
347	2, 101, 102, 103, 104, 171	6/21/2006	LN
347	4,5	1/20/07	W
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		11/20/0	1

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	104,2,4	11/20/07	LN
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (PGPUB, USPAT, EPO, JPO, DERWENT, IBM) Search note print out	6/21/2006	LN	
EHST (PGPUB, USPAT, EPO, JPO, DERWENT, IDAM) Scarch note protunt	11/20/07	W	
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